


| | | |
|--|--|---|
| Search Notes  | Application/Control No. 10530310 | Applicant(s)/Patent Under Reexamination CHAN ET AL. |
| | Examiner JASON K NIESZ | Art Unit 3751 |

| SEARCHED | | | |
|----------|----------------------------------|------------|----------|
| Class | Subclass | Date | Examiner |
| 141 | 21, 65 | 08/04/2009 | JN |
| 141 | 83, 94, 95 | 08/05/2009 | JN |
| 141 | 98, 192, 197, 234, 236, 248, 382 | 08/06/2009 | JN |
| 222 | 3, 174 | 08/06/2009 | JN |
| 248 | 636, 638 | 08/06/2009 | JN |

| SEARCH NOTES | | |
|---------------------|------------|----------|
| Search Notes | Date | Examiner |
| consulted Tim Maust | 08/04/2009 | JN |

| INTERFERENCE SEARCH | | | |
|---------------------|----------|------|----------|
| Class | Subclass | Date | Examiner |
| | | | |

| | |
|--|--|
| | |
|--|--|